

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

<p align="center">LIST OF PRIOR ART CITED BY APPLICANT (PTO-1449)</p>			ATTY. DOCKET NO. P-0652		APPLN. SERIAL NO. New U.S. Application		
			APPLICANT(S) Jik-Dong KIM				
			CUSTOMER NO. 34610				
			FILING DATE March 4, 2004		GROUP art unit		
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE	
U.S. PATENT APPLICATION PUBLICATIONS							
	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS		
	20003/0084400	05/01/2003	KAKU et al				
U.S. PATENT APPLICATIONS							
	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS		
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
/KMB/	2002-0074823	10/04/2002	KOREA			Abstract	
/KMB/	2003-249861	09/05/2003	JAPAN			Abstract	
/KMB/	WO 02-043275	05/30/2002	PCT			Abstract	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)							
EXAMINER	/Kevin M Burd/		DATE CONSIDERED	07/08/2007			

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\\f\k4\Documents\2000\2000-762\88837.doc

LIST OF ART CITED BY APPLICANT
(PTO-1449)



ATTY. DOCKET NO.
P-0652

APPLN. SERIAL NO.
10/792,131

APPLICANT(S)

Jik-Dong KIM

FILING DATE

March 4, 2004

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
/KMB/	5,991,284	11/23/1999	Willenegger et al.			
/KMB/	6,728,218	4/27/04	Corke et al.			

U.S. PATENT APPLICATION PUBLICATIONS

*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS
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FOREIGN PATENT DOCUMENTS

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

/KMB/	Chinese Office Action dated February 24, 2006

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MAY 08 2007

SHEET 1 OF 1

LIST OF ART CITED BY APPLICANT

ATTY. DOCKET NO.
P-0652

APPLN. SERIAL NO.
10/792,131

APPLICANT(S)

Jik-Dong KIM

FILING DATE
March 4, 2004

GROUP
2611

U.S. PATENT DOCUMENTS

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

*APPLN. NO. *FILING DATE *INVENTOR CLASS SUBCLASS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/KMB/	2001-148682	05/29/2001	JAPAN				Abstract
/KMB/	WO 02/093779	11/21/2002	PCT				X
/KMB/	EP 1 030 463	08/23/2000	EUROPE				X

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

European Search Report dated February 8, 2007

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